## **Book Reviews**

Works intended for notice in this column should be sent direct to the Book-Review Editor (M. M. Woolfson, Physics Department, University of York, Heslington, York YO1 5DD, England). As far as practicable books will be reviewed in a country different from that of publication.

Mössbauer effect methodology. Vol. 5. Edited by Irwin J. Gruverman. Pp.viii + 278. New York: Plenum Press, 1969. Price \$19.50.

This is the latest volume of a series aimed at providing 'a continuing forum for publication of developments in Mössbauer effect methodology and of spectroscopy and its applications'. Each volume records the proceedings of a symposium held annually in the U.S. under the sponsorship of the New England Nuclear Corporation. As in previous volumes the book is subdivided into sections; in this case Spectroscopy (6 reviews), Applications (4 reviews) and Methodology (5 reviews).

The spectroscopy section has a strong chemical-physics content with articles on semiconductor and organometallic Sn compounds; inorganic Sb compounds; organometallic compounds in noncrystalline matrices; Eu mixed oxide structures; and isomer shifts in Sn, Sb, Te, I, and Xe. The other review in this section deals with studies of vitamin  $B_{12}$  and related cobalamins.

In the applications section one article discusses polarization effects in single crystals. Another deals with the determination of zero-point phonon parameters and describes a new method of combining recoil-free fraction measurements with second order Doppler shifts so as to permit deduction of the absolute zero-point mean-square velocity. Such calculations should prove useful in testing theoretical models of impurities in crystal lattices. The third article in this section discusses the information obtainable from studies of microcrystals. This information relates to surface effects, 'internal pressures' (which can be as high as  $\pm 200$  kbar), preferential stabilization of various chemical valence states, and magnetic effects such as superparamagnetism. This section's final article discusses the after-effects of Auger ionization following electron capture in cobalt complexes.

The methodology section begins with a review of Mössbauer applications in radioactive materials, in which unstable isotopes may be used as absorbers thus expanding the field of nuclear and solid state investigations. A method of measuring diffusion by observing the broadening of Mössbauer lines is also discussed, although the method is not as 'new' as the authors claim since similar measurements were done on solids and liquids in the early sixties (Boyle, Bunbury, Edwards & Hall, Proc. Phys. Soc. (1961), 77, 129; Bunbury, Elliott, Hall & Williams, Phys. Letters (1963). 6, 34). A third article is of interest to mineralogists as it describes Mössbauer methods for determining mineral contents of rocks, ferric-ferrous ratios, etc. A final paper reviews the design and application of He<sup>3</sup>/He<sup>4</sup> dilution refrigerators to Mössbauer work. This is a relatively new development which opens up a whole new range for experiments requiring continuous temperatures down to 0.03K. The basic refrigerator principles are reviewed together with a description of the cryostat required. Applications include the observation of very low temperature magnetic transitions. paramagnetic relaxation, and localized magnetic moments including the Kondo effect. The use of the Mössbauer effect as an absolute thermometer is also described.

As a result of their wide coverage these volumes should be of interest to many physicists, chemists, biologists, metallurgists and geologists, and would form a valuable addition to their libraries. Most Mössbauer workers, however, will want to make more frequent reference to these books and idealy will want them closer at hand. This recent volume (and more are promised) is a most useful addition to the series, but it is the series as a whole which is to be recommended.

J. M. WILLIAMS

Physics Department University of Sheffield Sheffield Yorkshire England

Elements of X-ray crystallography. By A. J. C. WILSON. Pp.ix + 256. London: Addison-Wesley, 1970. Price £ 6.90.

This book fills a definite gap between several existing rather simple books on X-ray diffraction, in which its various applications are at best treated qualitatively correctly, and the more exhaustive and rigorous treatment of various text-books on powder diffractometry on one hand, and structure determination on the other.

To find a book of just over 200 pages adequately covering such different fields as systematic errors in powder diffractometry, intensity of X-ray diffraction, and diffraction by imperfect crystals, is quite a revelation to the university teacher who has in vain wrestled with the problem of how to cram all this into an introductory course. The reviewer notes with delight some clever didactic tricks, such as the derivation of the Patterson function. On the other hand, an introduction of vector notation right from the beginning of Chapter 8, instead of halfway through, would have had the advantage of avoiding introducing the non-informative notation ' $\theta_i$ ' for  $2\pi h.r_i$ .

Inevitably, some subjects have been carried further than others, clearly depending on the author's special interests. Especially these parts of the book provide very stimulating reading.

The chapter on crystal structure determination does show how fast this application of X-ray diffraction develops: although the book was apparently written in 1969, this part is already slightly outdated. For instance, the effectiveness of the sign-relation method of solving structures is definitely underestimated on p. 170; cf. the many successes scored by the Karles and others. Also, the heavy-atom method does not depend quite so much on 'favourable circumstances' as stated on p. 182, certainly not in the case of centrosymmetry and if three-dimensional Fourier methods are used. It might have been useful to point out that the Patterson and the sign-relation method are often complementary, in the sense that where one fails, there is a good chance that the other may be successful.